SDM3045X Digital Multimeter



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Product Overview

SDM3045X is a 4¹/₂ digit digital (60000 count) multimeter incorporating a dual-display and is especially well suited for the needs of high-precision, multifunction and automatic measurement.

Main Function

Basic Measurement Function

- IC Voltage: 600 mV ∼ 1000 V
- 🜆 DC Current: 600 μA ~ 10 A
- AC Voltage: True-RMS, 600 mV ~ 750 V
- AC Current: True-RMS,60 mA ~ 10 A
- 4-Wire Resistance: 600 Ω ~ 100 MΩ
- 🜆 Capacitance: 2 nF ~ 10000 μF
- In Continuity Test: Range is fixed at 2 kΩ
- Main Diode Test: Adjustable range is 0~4 V.
- 🜆 Frequency Measurement: 20 Hz ~ 500 KHz
- Image: Support for TC and RTD sensor
- Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement ,Pass/Fail Histogram, Trend Chart

User-friendly Design

4.3" TFT-LCD, 480*272 Support dual display, Chinese and English Menu Built-in front panel accessible help system File management (support for U-disc and local storage)

Application fields

- 🜆 Research Laboratory
- Development Laboratory
- Detection and Maintenance
- Calibration Laboratory
- Materia Production Test

Main Feature

- Real 41/2 digit (60000 count) readings resolution
- ✤ Up to 150 rdgs/s measurement speed
- True-RMS AC Voltage and AC Current measuring
- I Gb Nand flash size, Mass storage configuration files and data files
- Built-in cold terminal compensation for thermocouple
- With easy, convenient and flexible PC software: EasySDM
- Standard interface: USB Device, USB Host, LAN
- Supports remote control via commands and compatible with commands of main stream multimeters

Special Features

🜆 Histogram



🜆 Bar Chart

Auto Trig		Local
DC Voltage		
+6	.0000	VDC
	Manual 6V	
-6	0	+6
Display Horizonta	l I	
Bar Scale		

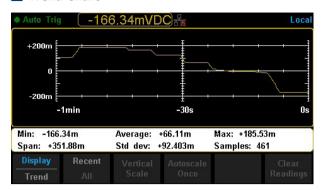
🛃 Dual Display



Image: Book of the second s



Trend Chart



Statistics

Auto Trig		₽ B <mark>X</mark>		Loca
DC Voltage Manual 6V	5.9	998		VDC
Min: -0.0018	Average:	overload V	Max:	overload V
Span: overload V	Std dev:	overload V	Samples	: 2.444k
Low Limit: -1.0000	High Limit:	+7.0000	Status:	Pass
Low Failures: 0	High Failur	es:61		
Statistics Show Hide			Clear Readin	llono

Hold Measurement

Single Trig				Dual	Loca
DC Voltage	e 1	10			
6V	<u>+</u> T	<u>. т</u>	953		
Live: +1.1953	VDC				
1: +2.0006	VDC		5: +2.1936	VDC	
2: +2.0997	VDC		6: +5.2312	VDC	
3: +1.6055	VDC		7: +07.242	VDC	
4: +3.2351	VDC		8: +1.1954	VDC	
Probe Hold Be On Off On	eeper Off		(Clear List	

Interface



Specifications

DC Characteristic

Accuracy \pm (% of Reading + count)^[1]

Function	Range ^[2]	Test current or Load voltage	Resolution	Accuracy (one year; 23℃ ±5℃)
	600 mV		0.01 mV	0.01+ 5
	6 V		0.0001 V	0.01+ 6
DC Voltage	60 V		0.001 V	0.02+ 4
	600 V		0.01 V	0.02+ 6
	1000 V ^[4]		0.1 V	0.02+ 6
	600 µA	< 33 mV	0.01 µA	0.05+ 3
	6 mA	< 330 mV	0.0001 mA	0.05+ 3
DC Current	60 mA	< 0.05 V	0.001 mA	0.05+ 3
DC Current	600 mA	< 0.5 V	0.01 mA	0.12+ 6
	6 A	< 0.33 V	0.0001 A	0.20+ 5
	10 A ^[5]	< 0.6 V	0.001 A	0.25+ 4
	600 Ω	1 mA	0.01 Ω	0.04+ 5
	6 ΚΩ	1 00 µA	0.0001 ΚΩ	0.02+ 5
	60 ΚΩ	10 µA	0.001 ΚΩ	0.02+ 5
Resistance ^[3]	600 ΚΩ	1 µA	0.01 ΚΩ	0.04+ 5
	6 ΜΩ	200 nA	0.0001 ΜΩ	0.12+ 3
	60 MΩ	200 nA 10 MΩ	0.001 MΩ	0.85+ 3
	100 MΩ	200 nA 10 MΩ	0.01 MΩ	1.75+ 3
Diode Test ^[6]	0~2 V	1 mA	0.0001 V	0.05+ 3
	2~4 V	1 mA	0.0001 V	0.35+ 3
Continuity Test	2000 Ω	1 mA	0.1 Ω	0.05+ 3

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18° ~ 28° . [2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A. [3] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. $\pm 0.2 \Omega$ of extra errors will be generated if perform 2-wire measure without "REF" operation.

[4] Plus 0.02 mV of error per 1 V after the first ±500 VDC.

[5] 30 seconds OFF after 30 seconds ON is recommend foe the continuous current that higher than DC 7 A or AC RMS 7 A.
 [6] Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply. Adjustable voltage range : 0~ 4 V.



AC Characteristic

Accuracy \pm (% of Reading + count)¹

AC Characteristic				Accuracy± (% of Reading + count) ²	
Function	Range ^[2]	Frequency Range	Resolution	Accuracy (one year; 23℃ ±5℃)	
		20 Hz – 45 Hz	0.01 mV	2.0 + 20	
		45 Hz – 100 Hz	0.01 mV	0.6 +10	
	600 mV	100 Hz – 20 KHz	0.01 mV	0.2 + 10	
		20 KHz – 50 KHz	0.01 mV	1.0 + 10	
		50 KHz –100 KHz	0.01 mV	3.0 + 10	
		20 Hz – 45 Hz	0.0001 V	2.0 + 20	
		45 Hz – 100 Hz	0.0001 V	0.6 + 10	
	6 V	100 Hz – 20 KHz	0.0001 V	0.2 + 10	
		20 KHz – 50 KHz	0.0001 V	1.0 + 10	
		50 KHz –100 KHz	0.0001 V	3.0 + 10	
		20 Hz – 45 Hz	0.001 V	2.0 + 20	
		45 Hz – 100 Hz	0.001 V	0.6 +10	
True-RMS AC Voltage [3]	60 V	100 Hz – 20 KHz	0.001 V	0.2 + 10	
AC Voltage		20 KHz – 50 KHz	0.001 V	1.0 + 10	
		50 KHz –100 KHz	0.001 V	3.0 + 10	
		20 Hz – 45 Hz	0.01 V	2.0 + 20	
		45 Hz – 100 Hz	0.01 V	0.6 + 10	
	600 V	100 Hz – 20 KHz	0.01 V	0.2 + 10	
		20 KHz – 50 KHz	0.01 V	1.0 + 10	
		50 KHz –100 KHz	0.01 V	3.0 + 10	
		20 Hz – 45 Hz	0.01 V	2.0 + 20	
		45 Hz – 100 Hz ^[4]	0.01 V	0.6 + 10	
	750 V	100 Hz – 20 KHz	0.01 V	0.2 + 10	
		20 KHz – 50 KHz	0.01 V	1.0 + 10	
		50 KHz –100 KHz	0.01 V	3.0 + 10	
		20 Hz – 45 Hz	0.001 mA	2.0 + 20	
	60 mA	45 Hz – 2 KHz	0.001 mA	0.5 + 20	
		2 KHz – 10 KHz	0.001 mA	2.5 + 30	
		20 Hz – 45 Hz	0.01 mA	2.0 + 20	
	600 mA	45 Hz – 2 KHz	0.01 mA	0.5 + 20	
True-RMS		2 KHz – 10 KHz	0.01 mA	2.5 + 30	
AC Current ^[5]		20 Hz – 45 Hz	0.0001 A	2.0 + 20	
	6 A	45 Hz – 2 KHz	0.0001 A	0.5 + 20	
		2 KHz – 10 KHz	0.0001 A	2.5 + 20	
		20 Hz – 45 Hz	0.001 A	1.5 + 15	
	10 A ^[6]	45 Hz – 2 KHz	0.001 A	0.5 + 15	
		2 KHz – 10 KHz	0.001 A	2.5 + 25	
	A .1.1***	onal wave crest factor erro	·· (·· •• • • • • • • • • • • • • • • •		

Additional wave crest factor error (not Sine) [7]				
Wave crest coefficient	Error (% Range)			
1-2	0.05			
2-3	0.3			

Remarks: [1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18° C ~ 28° C . [2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and <50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.

[4] Plus 0.025 V of error per 1 V after the first ±400 VAC.
[5] Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5%.
[6] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.
[7] For inputs Frequency Range < 100 Hz

Frequency and Period Characteristic

Accuracy \pm (% of Reading + count)^[1]

Function	Range	Frequency Range	Resolution	Accuracy (one year; 23℃ ±5℃)
Frequency /Period 600 mV to 750 V ^[2]	20 Hz – 2 KHz		0.01+3	
	$600 \text{ mV} = 750 \text{ V}^{[2]}$	2 KHz – 20 KHz		0.01+2
	20 KHz – 200 KHz		0.01+2	
		200 KHz –500 KHz		0.01+2

Remarks:

[1] Specifications are for 0.5 Hour warm-up.

[2] Except for special marks, the AC input voltage is 5% to 110% of range when <100 kHz and 10% to 110% of range when >100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of Reading when the measurement range of AC voltage is in 600 mV range.

Capacitance Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range ^[2]	Max Testing Current	Resolution	Accuracy (one year; 23℃ ±5℃)
	2 nF	10 µA	0.001 nF	3+10
	20 nF	10 µA	0.01 nF	1+10
	200 nF	100 µA	0.1 nF	1+9
Capacitance	2 µF	100 µA	0.001 µF	1+10
	20 µF	1 mA	0.01 µF	1+10
	200 µF	1 mA	0.1 µF	1+9
	10000 µF	1 mA	1 µF	2+50

Remarks:

[1] Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors. [2] Specifications are for from 1% to 110% on 2 nF range and ranges from 10% to 110% on other ranges.

Temperature Characteristic

Temperature Characteristic Accuracy± (% of Reading) ^[1]					
Function	Probe Type	Probe Model	Working Temperature Range	Accuracy (one year; 23℃ ±5℃)	Temperature coefficient 0°C ~ 18°C 28°C ~ 5 0°C
	RTD ^[2]	a=0.00385	-200℃ ~ 660℃	0.16℃	0.09℃
		В	0℃ ~ 1820℃	0.76 ℃	0.14℃
		E	-270℃ ~ 1000℃	0.5℃	0.02℃
		J	-210℃ ~ 1200℃	0.5℃	0.02℃
Temperature	TC ^[3]	К	-270℃ ~ 1370℃	0.5℃	0.03℃
	10.1	Ν	-270℃ ~ 1300℃	0.5℃	0.04℃
		R	-50℃ ~ 1760℃	0.5℃	0.09 ℃
		S	-50℃ ~ 1760℃	0.6℃	0.11℃
		Т	-270℃ ~ 400℃	0.5℃	0.03°C

Remarks:

[1] Specifications are for 0.5 Hour warm-up, not include probe error. [2] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. [3] Built-in cold terminal compensation for thermocouple, accuracy is $\pm 2^{\circ}$.

Measuring Method and other Characteristics

DC Voltage	d other Characteristics				
Input Resistance	600 mV 10 MΩ or 10 GΩ selectab				
	6 V,60 V, 600 V and 1000 V Range 10 MΩ	± 2%			
Input Bias Current	<90 pA, 25°C				
Input Protection	1000 V on all ranges				
CMRR	120 dB (For the 1 K Ω unbalanced resistance in LO lead, max ±500 VDC)				
NMRR	60 dB at "slow" measurement rate				
Resistance					
Testing Method	4-wire resistance or 2-wire resistance selecta	ble			
Input Protection	1000 V on all ranges				
DC Current					
	600 μ A sampling voltage < 33 mV				
Shunt Resistor	6 mA sampling voltage < 0.33 V				
	1Ω for 60 mA, 600 mA 1 Ω				
	0.01 Ω for 6 A, 10 A				
Input Protection	Rear panel : accessible 10 A,250 V fast-melt	fuse			
	Internal :12 A,250 V slow-melt fuse				
Continuity/Diode Tes	t				
Measurement Method	1 mA ±5% constant-current source or open-	circuit voltage			
Beeper	yes				
Continuity Threshold	Adjustable				
Input Protection	1000 V				
True-RMS AC Voltage					
Measurement Method	AC Coupled true RMS measure – up to 1000	V DC bias are permitted on every range.			
Wave Crest Factor	≤3 at full scale				
Input Impedance	$1~\text{M}\Omega$ \pm 2% in parallel with <100 pF on all ra	nges			
AC Filter Bandwidth	20 Hz ~ 100 KHz				
CMRR	60 dB (For the 1 K Ω imbalance resistance am	nong Lo lead and <60 Hz, Max ±500 VDC)			
True-RMS AC Current					
Measurement Method	DC Coupled to the fuse and shunt; AC Couple	DC Coupled to the fuse and shunt; AC Coupled the True-RMS measurement (measures the AC components only)			
Wave Crest Factor	≤3 at full scale				
Max Input	<10 A (include DC component)				
Shunt Resistor	1 Ω for 60 mA, 600 mA 1 Ω ; 0.01 Ω for 6 A, 10 A				
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse				
·	Internal :12 A,250 V slow-melt fuse				
Frequency/Period					
Measurement Method	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function				
Measure Attentions	• •	vhen measuring low voltage or low frequency signal.			
Capacitance Measurin	ng				
Measurement Method	Measure the rate of change of voltage genera	ated during the current flowing the capacitance			
Connection Type	2-wire				
Input Protection	1000 V on all ranges				
	1000 V off all ranges				
Temperature Measuri	-				
Temperature Measuri Measurement Method	-				
-	ing				
Measurement Method	ing				
Measurement Method Trigger and Memory	Support for TC and RTD types of sensor				
Measurement Method Trigger and Memory Samples/Trigger	Support for TC and RTD types of sensor 1 ~ 10000	TTL compatible (High level when left input terminal is hanging in the air)			
Measurement Method Trigger and Memory Samples/Trigger	Support for TC and RTD types of sensor 1 ~ 10000 6 ms ~ 10000 ms optional				
Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Support for TC and RTD types of sensor 1 ~ 10000 6 ms ~ 10000 ms optional Input Level	in the air)			
Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Support for TC and RTD types of sensor 1 ~ 10000 6 ms ~ 10000 ms optional Input Level Trigger Condition	in the air) Rising and Falling selectable			
Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Support for TC and RTD types of sensor 1 ~ 10000 6 ms ~ 10000 ms optional Input Level Trigger Condition Input Impedance	in the air) Rising and Falling selectable \geq 20 KΩ//400 pF ,DC-coupled			
Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Support for TC and RTD types of sensor 1 ~ 10000 6 ms ~ 10000 ms optional Input Level Trigger Condition Input Impedance Min Pulse	in the air) Rising and Falling selectable $\geq 20 \text{ K}\Omega//400 \text{ pF}$,DC-coupled 500 us			

History Records	
Volatile Memory	10 K reading of history records
Nonvolatile Memory	1 Gb Nand Flash, Mass storage configuration files and data files, Support U-disk external storage
Math Functions	

Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, histogram, Trend chart, Bar chart

General Specifications

Power Supply			
AC 100 V ~ 120 V	45 Hz ~ 66 Hz		
AC 200 V ~ 240 V	45 Hz ~ 66 Hz		
Consumption	20VA max		
Mechanism			
Dimension	293.75 mm×260.27 mm×107.21 mm		
Weight	3.76 Kg		
Other Characteristics			
Display Screen	4.3" TFT-LCD with resolution 480*272		
	Full accuracy from $0^\circ\!\mathbb{C}$ to $50^\circ\!\mathbb{C}$, 80% RH and $40^\circ\!\mathbb{C}$, non condensing		
Operation Environment	Storage Temperature: -20°C -70°C		
	Shock and Vibration: conforming to MIL-T-28800E, , 5 level (only foe sine)		
	Height above sea level: up to 3000 meters		
electromagnetic compatibility	Conforming to EMC (2004/108/EC) and EN 61326-1:2013		
Safety	Conforming to EN61010-1:2010 and low voltage instructions (2006/95/EC)		
Remote Interface	10/100 Mbit LAN, USB2.0 Full Speed Device and Host		
Programmer Language	Standard SCPI, compatible with commands of main stream multimeters		
Warm Up Time	30 minutes		

Purchase Information

Product name	SIGLENT SDM3045X Digital Multimeter
Models	SDM3045X
Standard Accessories	A power Cord that fits the standard of destination country
	Two Test Leads, Two Alligator Clips
	A USB Cable
	A Quick Start
	A Guaranty Card
	A CD (Including EasySDM computer software system)

SDM3045X Digital Multimeter



About SIGLENT

SIGLENT is an international high-tech company, concentrating on R&D, sales, production and services of electronic test & measurement instruments.

SIGLENT first began developing digital oscilloscopes independently in 2002. After more than a decade of continuous development, SIGLENT has extended its product line to include digital oscilloscopes, function/arbitrary waveform generators, digital multimeters, DC power supplies, spectrum analyzers, isolated handheld oscilloscopes and other general purpose test instrumentation. Since its first oscilloscope, the ADS7000 series, was launched in 2005, SIGLENT has become the fastest growing manufacturer of digital oscilloscopes. We firmly believe that today SIGLENT is the best value in electronic test & measurement.

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